Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
09/667,122	MOYER ET AL.
Examiner	Art Unit
David J. Huisman	2183

	SEARCHED			
Class	Subclass	Date	Examiner	
			<u> </u>	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<b>1</b>			

SEARCH N (INCLUDING SEARC		·)
	DATE	EXMR
Updated EAST Search	5/11/2005	DJH